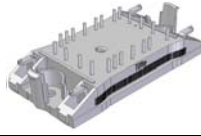
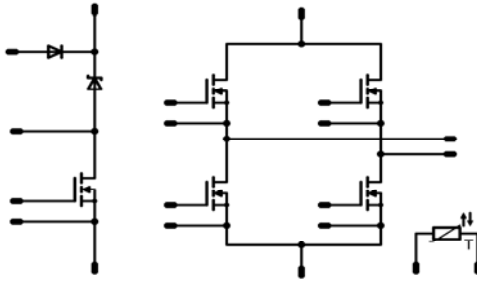


flowSOL 0 BI	600V/30A
<div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Features</p> <ul style="list-style-type: none"> High efficiency Ultra fast switching frequency Low inductive design SiC in boost </div> <div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Target Applications</p> <ul style="list-style-type: none"> Transformerless solar inverters </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Types</p> <ul style="list-style-type: none"> FZ06BIA083FI </div>	<div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">flow0 housing</p>  </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Schematic</p>  </div>

Maximum Ratings

$T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Bypass Diode				
Repetitive peak reverse voltage	V_{RRM}		600	V
Forward current per diode	I_{FAV}	DC current	$T_h=80^\circ\text{C}$ 49	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$	$T_j=25^\circ\text{C}$ 370	A
I2t-value	I^2t		$T_j=150^\circ\text{C}$ 360	A^2s
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$ 63	W
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$
Input Boost MOSFET				
Drain to source breakdown voltage	V_{DS}		600	V
DC drain current	I_D	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$ 37	A
Pulsed drain current	I_{Dpulse}	t_p limited by T_{jmax}	230	A
Power dissipation	P_{tot}	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$ 139	W
Gate-source peak voltage	V_{GS}		± 20	V
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$

Maximum Ratings

 $T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit	
Input Boost Diode					
Peak Repetitive Reverse Voltage	V_{RRM}	$T_j=25^{\circ}\text{C}$	600	V	
DC forward current	I_F	$T_j=T_{jmax}$	$T_h=80^{\circ}\text{C}$	20	A
			$T_c=80^{\circ}\text{C}$	25	
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	70	A	
Power dissipation	P_{tot}	$T_j=T_{jmax}$	$T_h=80^{\circ}\text{C}$	41	W
			$T_c=80^{\circ}\text{C}$	62	
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}\text{C}$	

Boost and Buck MOSFET

Drain to source breakdown voltage	V_{DS}		600	V	
DC drain current	I_D	$T_j=T_{jmax}$	$T_h=80^{\circ}\text{C}$	17	A
			$T_c=80^{\circ}\text{C}$	20	
Pulsed drain current	I_{Dpulse}	t_p limited by T_{jmax}	$T_c=25^{\circ}\text{C}$	85	A
Power dissipation	P_{tot}	$T_j=T_{jmax}$	$T_h=80^{\circ}\text{C}$	74	W
			$T_c=80^{\circ}\text{C}$	111	
Gate-source peak voltage	V_{gs}		± 20	V	
Maximum Junction Temperature	T_{jmax}		150	$^{\circ}\text{C}$	

Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	T_{op}		-40...+($T_{jmax} - 25$)	$^{\circ}\text{C}$

Insulation Properties

Insulation voltage	V_{is}	$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit	
		$V_{GE}[V]$ or $V_{GS}[V]$	$V_r[V]$ or $V_{CE}[V]$ or $V_{DS}[V]$	$I_c[A]$ or $I_F[A]$ or $I_D[A]$	T_j	Min	Typ	Max			
Bypass Diode											
Forward voltage	solar invert				15	$T_j=25^\circ C$ $T_j=125^\circ C$	0,7	1,01 0,93	1,3	V	
Threshold voltage (for power loss calc. only)	V_{td}					$T_j=25^\circ C$ $T_j=125^\circ C$		0,86 0,75		V	
Slope resistance (for power loss calc. only)	r_t					$T_j=25^\circ C$ $T_j=125^\circ C$		0,012		Ω	
Reverse current	I_r			1200		$T_j=25^\circ C$ $T_j=125^\circ C$			0,05	mA	
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 1 W/mK$						1,68		K/W	
Input Boost MOSFET											
Static drain to source ON resistance	$R_{DS(on)}$		10		44	$T_j=25^\circ C$ $T_j=125^\circ C$		0,04 0,09		Ω	
Gate threshold voltage	$V_{(GS)th}$	VGS=VDS			0,003	$T_j=25^\circ C$ $T_j=125^\circ C$	2,1	3	3,9	V	
Gate to Source Leakage Current	I_{gss}		20	0		$T_j=25^\circ C$ $T_j=125^\circ C$			200	nA	
Zero Gate Voltage Drain Current	I_{dss}		0	600		$T_j=25^\circ C$ $T_j=125^\circ C$			25	μA	
Turn On Delay Time	$t_{d(ON)}$	Rgoff=4 Ω Rgon=4 Ω	10	400	15	$T_j=25^\circ C$ $T_j=125^\circ C$		28 27		ns	
Rise Time	t_r					$T_j=25^\circ C$ $T_j=125^\circ C$		5 6			
Turn off delay time	$t_{d(OFF)}$					$T_j=25^\circ C$ $T_j=125^\circ C$		154 167			
Fall time	t_f					$T_j=25^\circ C$ $T_j=125^\circ C$		10 9			
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ C$ $T_j=125^\circ C$		0,063 0,072			mWs
Turn-off energy loss per pulse	E_{off}					$T_j=25^\circ C$ $T_j=125^\circ C$		0,025 0,025			
Total gate charge	Q_g					Rgon=4 Ω	10	400	44		$T_j=25^\circ C$ $T_j=125^\circ C$
Gate to source charge	Q_{gs}	$T_j=25^\circ C$ $T_j=125^\circ C$		34							
Gate to drain charge	Q_{gd}	$T_j=25^\circ C$ $T_j=125^\circ C$		51							
Input capacitance	C_{iss}	f=1MHz	0	100		$T_j=25^\circ C$		6800		pF	
Output capacitance	C_{oss}								320		
Reverse transfer capacitance	C_{rss}								48		
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 1 W/mK$						0,76		K/W	
Input Boost Diode											
Forward voltage	V_F				16	$T_j=25^\circ C$ $T_j=150^\circ C$	1	1,54 1,71	1,8	V	
Reverse leakage current	I_{rm}		10	400	15	$T_j=25^\circ C$ $T_j=150^\circ C$			400	μA	
Peak recovery current	I_{RRM}	Rgon=4 Ω	10	400	15	$T_j=25^\circ C$ $T_j=150^\circ C$		17 15		A	
Reverse recovery time	t_{rr}					$T_j=25^\circ C$ $T_j=150^\circ C$		9 10			
Reverse recovery charge	Q_{rr}					$T_j=25^\circ C$ $T_j=150^\circ C$		0,058 0,064			μC
Reverse recovered energy	E_{rec}					$T_j=25^\circ C$ $T_j=150^\circ C$		0,005 0,006			
Peak rate of fall of recovery current	$di(rec)max/dt$					$T_j=25^\circ C$ $T_j=150^\circ C$		4244 2752			A/ μs
Thermal resistance chip to heatsink per chip	R_{thJH}					Thermal grease thickness $\leq 50\mu m$ $\lambda = 1 W/mK$					

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}[V]$ or $V_{GS}[V]$	$V_r[V]$ or $V_{CE}[V]$ or $V_{DS}[V]$	$I_c[A]$ or $I_F[A]$ or $I_D[A]$	T_j	Min	Typ	Max		
Boost and Buck MOSFET										
Static drain to source ON resistance	$R_{ds(on)}$		10		21,6	$T_j=25^\circ C$ $T_j=125^\circ C$		118 233		m Ω
Gate threshold voltage	$V_{(GS)th}$		VDS=VGS		0,0019	$T_j=25^\circ C$ $T_j=125^\circ C$	3	4	5	V
Gate to Source Leakage Current	I_{gss}		20	0		$T_j=25^\circ C$ $T_j=125^\circ C$			200	nA
Zero Gate Voltage Drain Current	I_{dss}		0	600		$T_j=25^\circ C$ $T_j=125^\circ C$			25	μA
Turn On Delay Time	$t_{d(ON)}$	Rgon=16 Ω Rgoff=4 Ω	10	400	15	$T_j=25^\circ C$		58		ns
Rise Time	t_r					$T_j=125^\circ C$		55		
Turn off delay time	$t_{d(OFF)}$					$T_j=25^\circ C$		22		
						$T_j=125^\circ C$		23		
Fall time	t_f					$T_j=25^\circ C$		126		
						$T_j=125^\circ C$		134		
Turn-on energy loss per pulse	E_{on}									
Turn-off energy loss per pulse	E_{off}					$T_j=125^\circ C$		1,54 2,27		
Total gate charge	Q_g					$T_j=25^\circ C$		0,01 0,02		
Gate to source charge	Q_{gs}		10	480	46	$T_j=25^\circ C$		163		nC
Gate to drain charge	Q_{gd}							36		
Input capacitance	C_{iss}							87		
Output capacitance	C_{oss}	f=1MHz	0	25		$T_j=25^\circ C$		5060		pF
Reverse transfer capacitance	C_{rss}							1400		
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness \leq 50 μm $\lambda = 1$ W/mK						16		
Thermistor										
Rated resistance*	R_{25}					$T_j=25^\circ C$	17,5	22	29,0	k Ω
	R_{100}	Tol. $\pm 5\%$						1486		Ω
Power dissipation	P					$T_j=25^\circ C$		210		mW
B-value	$B_{(25/100)}$	Tol. $\pm 3\%$				$T_j=25^\circ C$		4000		K

 * see details on **Thermistor** charts on **Figure 2**.

Boost and Buck

Figure 1 MOSFET

Typical output characteristics

$I_C = f(V_{CE})$

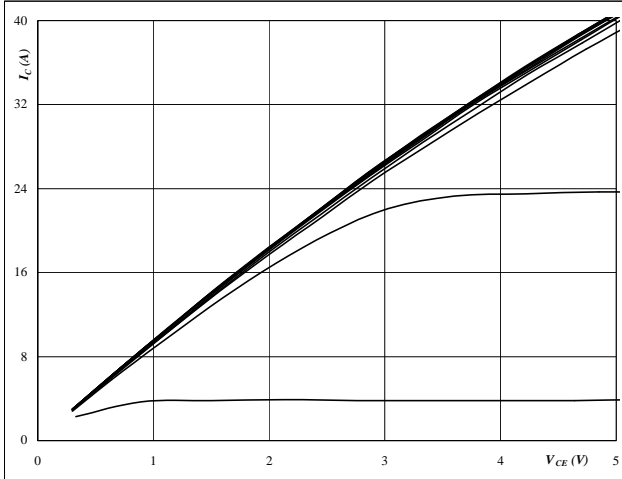

At
 $t_p = 250 \mu\text{s}$
 $T_j = 25 \text{ }^\circ\text{C}$
 V_{GE} from 6 V to 16 V in steps of 1 V

Figure 2 MOSFET

Typical output characteristics

$I_C = f(V_{CE})$

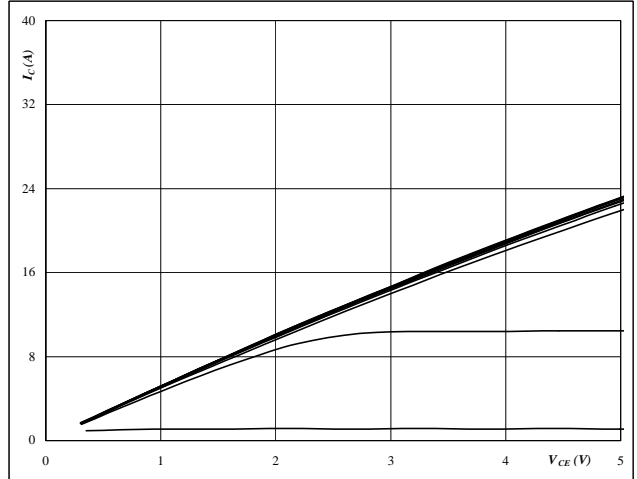
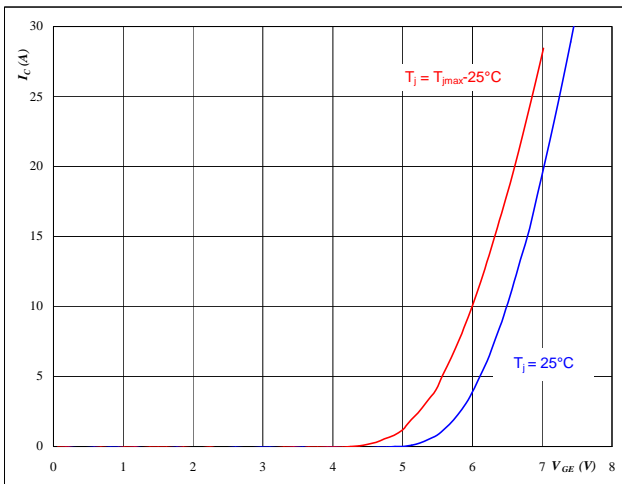

At
 $t_p = 250 \mu\text{s}$
 $T_j = 125 \text{ }^\circ\text{C}$
 V_{GE} from 6 V to 16 V in steps of 1 V

Figure 3 MOSFET

Typical transfer characteristics

$I_C = f(V_{GE})$

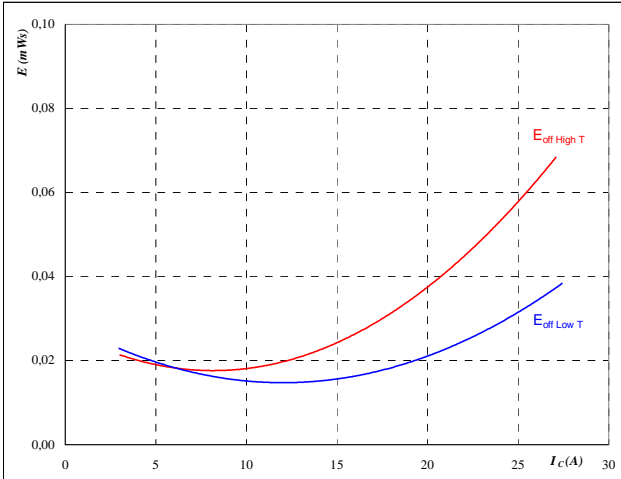

At
 $t_p = 250 \mu\text{s}$
 $V_{CE} = 10 \text{ V}$

Boost and Buck

Figure 4 MOSFET

Typical switching energy losses
as a function of collector current

$$E = f(I_C)$$



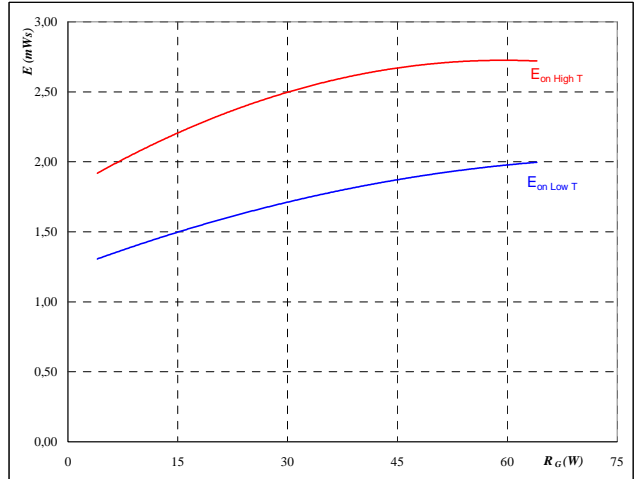
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	16	Ω
$R_{goff} =$	4	Ω

Figure 5 MOSFET

Typical switching energy losses
as a function of gate resistor

$$E = f(R_G)$$



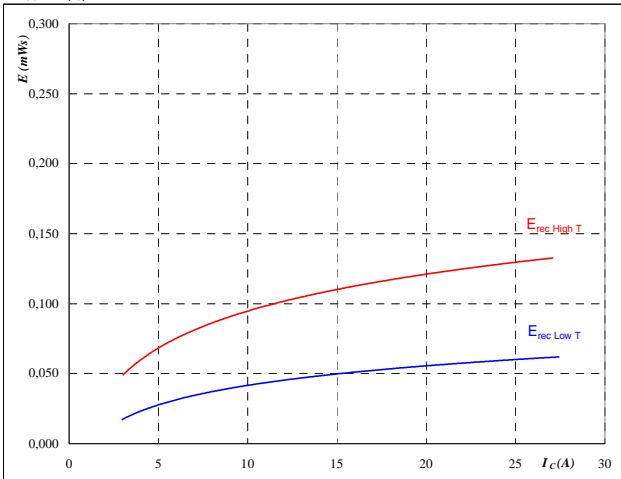
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$I_C =$	15	A

Figure 6 FRED

Typical reverse recovery energy loss
as a function of collector current

$$E_{rec} = f(I_C)$$



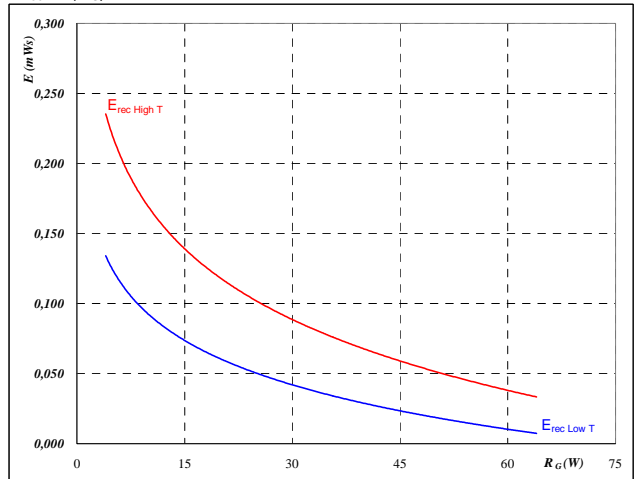
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	16	Ω

Figure 7 FRED

Typical reverse recovery energy loss
as a function of gate resistor

$$E_{rec} = f(R_G)$$



With an inductive load at

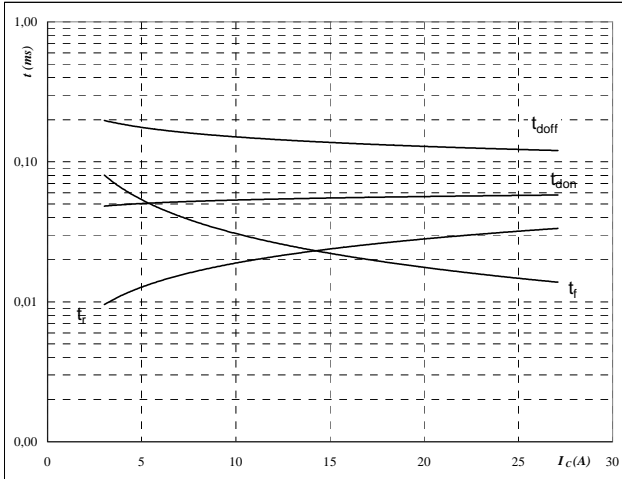
$T_J =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$I_C =$	15	A

Boost and Buck

Figure 8 MOSFET

Typical switching times as a function of collector current

$t = f(I_C)$



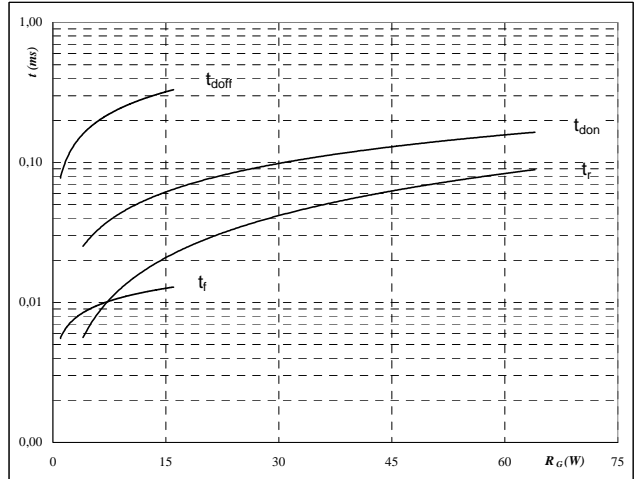
With an inductive load at

$T_J =$	125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	16	Ω
$R_{goff} =$	4	Ω

Figure 9 MOSFET

Typical switching times as a function of gate resistor

$t = f(R_G)$



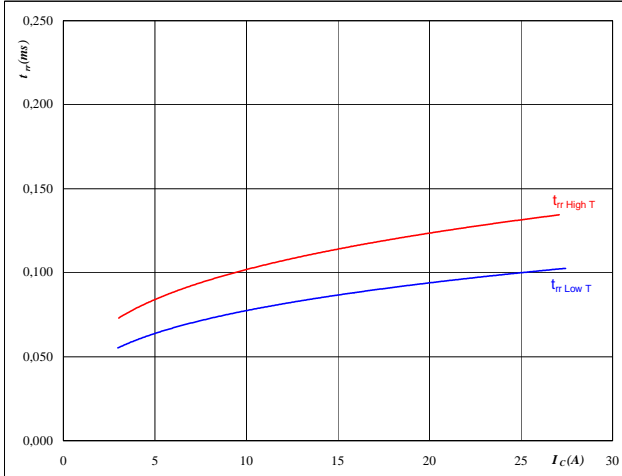
With an inductive load at

$T_J =$	125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$I_C =$	15	A

Figure 10 FRED

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

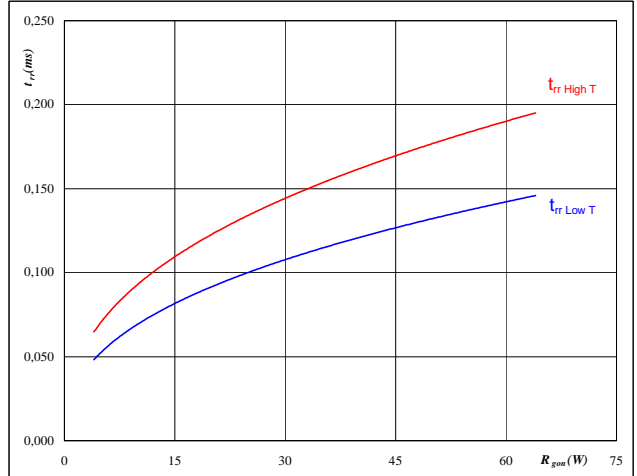

At

$T_J =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	16	Ω

Figure 11 FRED

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$


At

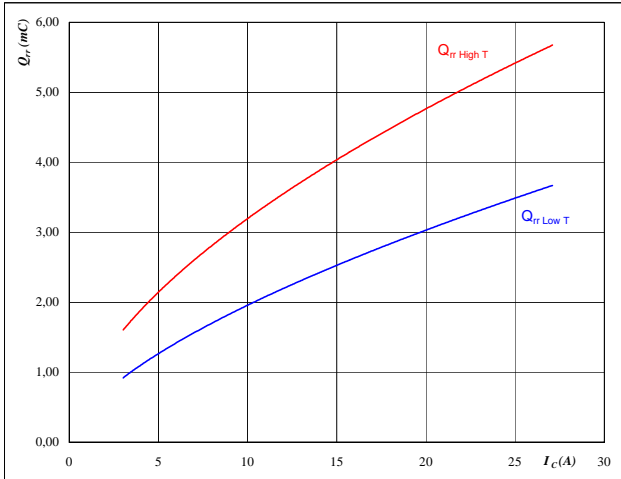
$T_J =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GE} =$	10	V

Boost and Buck

Figure 12 FRED

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_c)$$

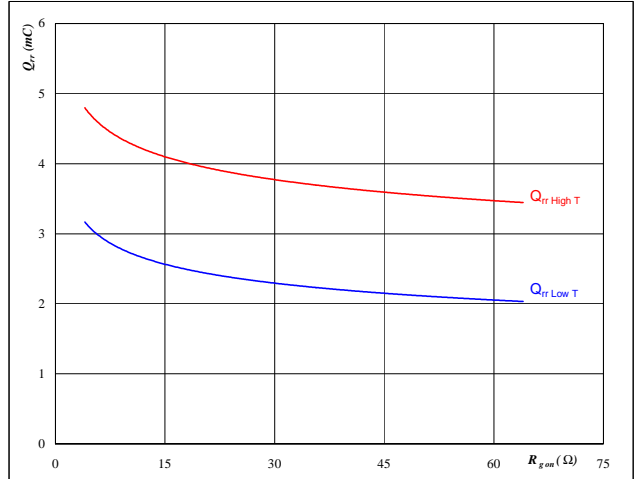


At
 $T_j = 25/125$ °C
 $V_{CE} = 400$ V
 $V_{GE} = 10$ V
 $R_{gon} = 16$ Ω

Figure 13 FRED

Typical reverse recovery charge as a function of MOSFET turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

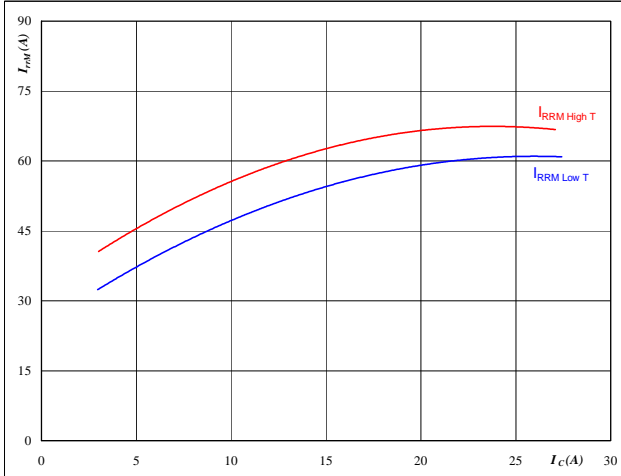


At
 $T_j = 25/125$ °C
 $V_R = 400$ V
 $I_F = 15$ A
 $V_{GE} = 10$ V

Figure 14 FRED

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_c)$$

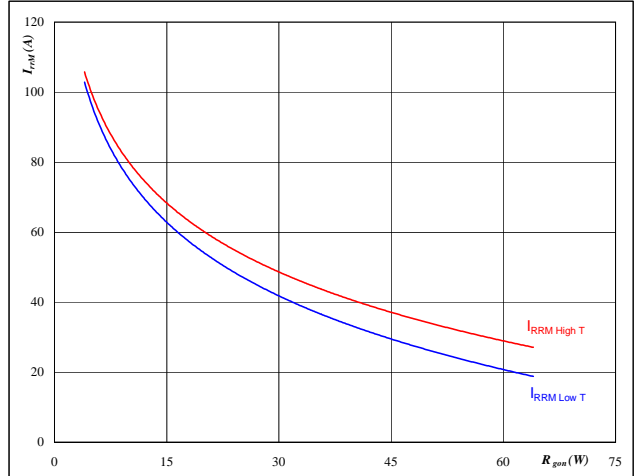


At
 $T_j = 25/125$ °C
 $V_{CE} = 400$ V
 $V_{GE} = 10$ V
 $R_{gon} = 16$ Ω

Figure 15 FRED

Typical reverse recovery current as a function of MOSFET turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



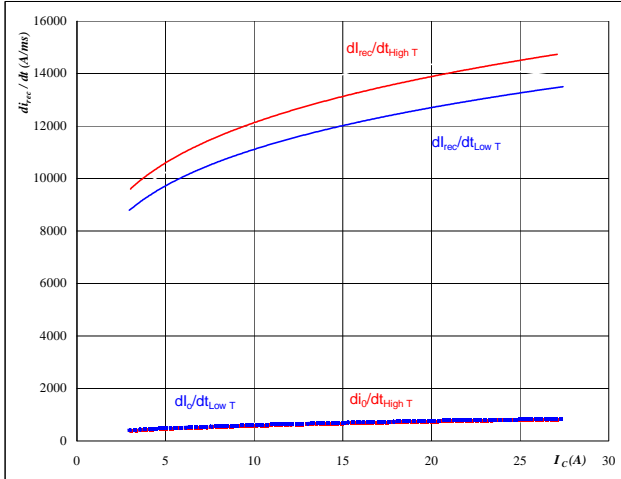
At
 $T_j = 25/125$ °C
 $V_R = 400$ V
 $I_F = 15$ A
 $V_{GE} = 10$ V

Boost and Buck

Figure 16 FRED

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$dI_f/dt, dI_{rec}/dt = f(I_c)$$

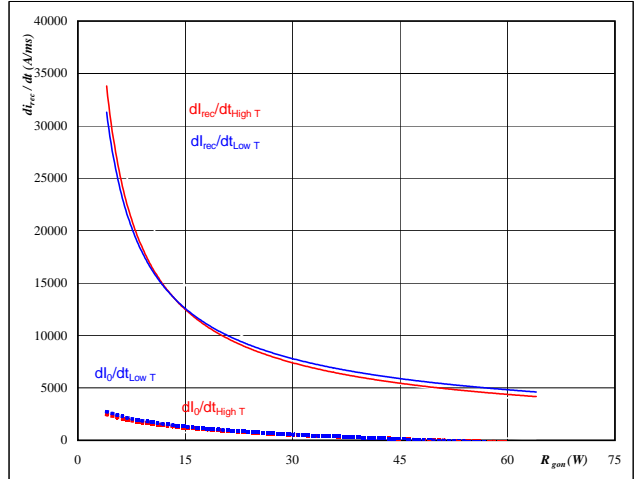


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 400 \text{ V}$
 $V_{GE} = 10 \text{ V}$
 $R_{gon} = 16 \text{ } \Omega$

Figure 17 FRED

Typical rate of fall of forward and reverse recovery current as a function of MOSFET turn on gate resistor

$$dI_f/dt, dI_{rec}/dt = f(R_{gon})$$

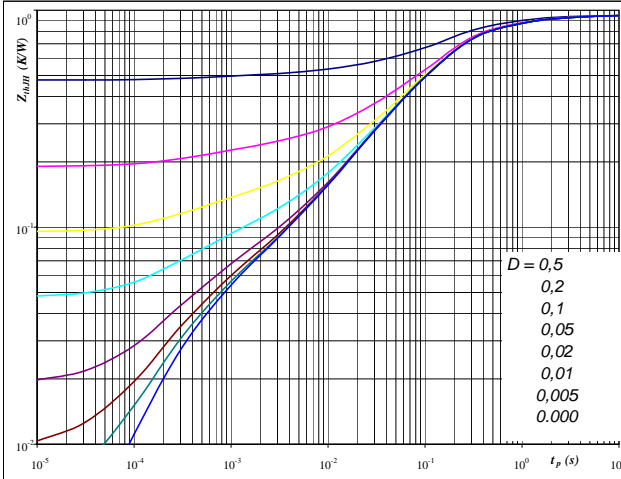


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 400 \text{ V}$
 $I_F = 15 \text{ A}$
 $V_{GE} = 10 \text{ V}$

Figure 18 MOSFET

MOSFET transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 0,95 \text{ K/W}$

IGBT thermal model values

R (C/W)	Tau (s)
0,03	6,6E+00
0,15	9,3E-01
0,55	1,6E-01
0,14	2,5E-02
0,04	2,6E-03
0,03	3,4E-04

Boost and Buck

Figure 19 MOSFET

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

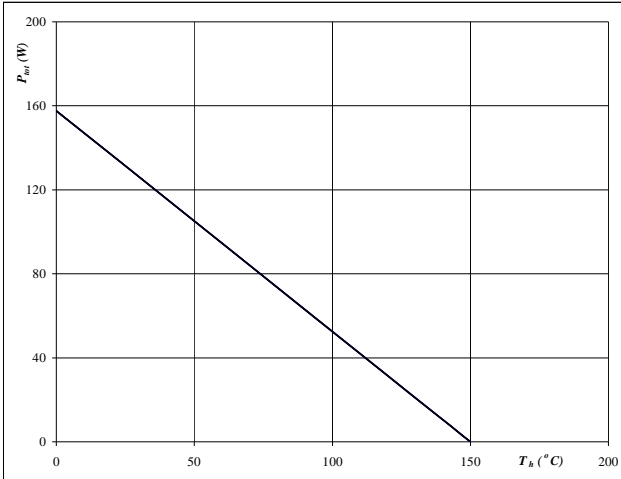

At
 $T_j = 150$ °C

Figure 20 MOSFET

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$

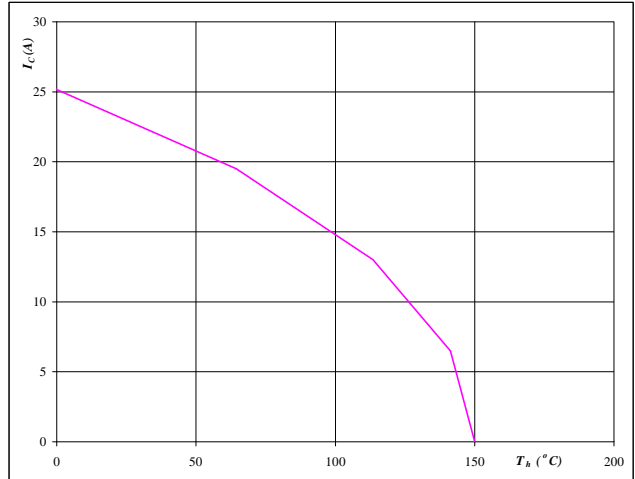

At
 $T_j = 150$ °C
 $V_{GE} = 15$ V

Figure 21 MOSFET

Safe operating area as a function of collector-emitter voltage

$$I_C = f(V_{CE})$$

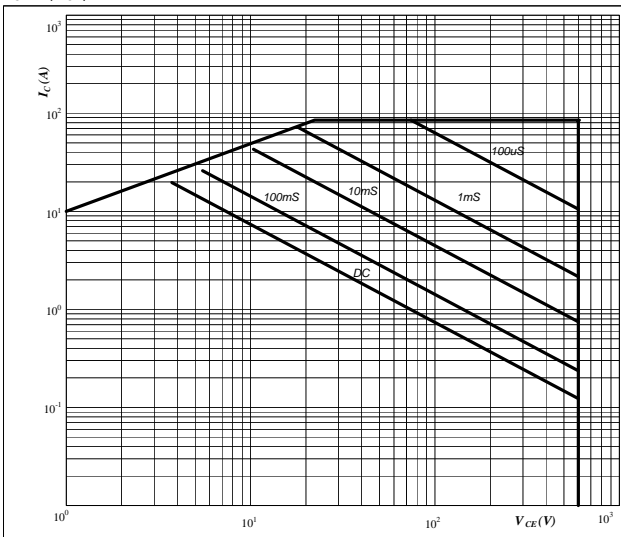
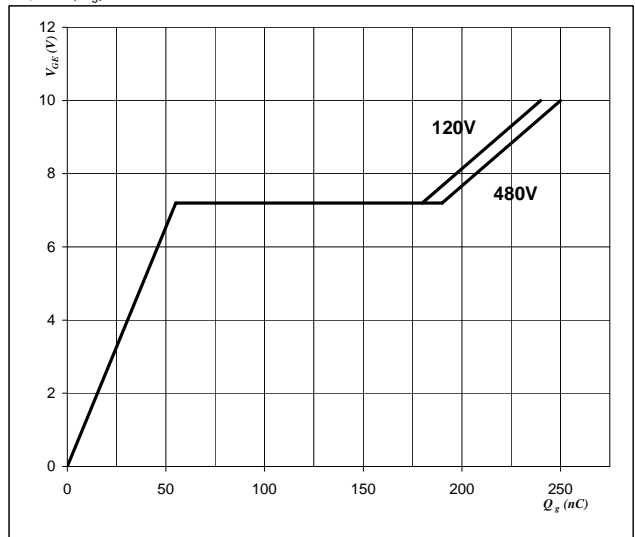

At
 $D =$ single pulse
 $T_h = 80$ °C
 $V_{GE} = 15$ V
 $T_j = T_{jmax}$ °C

Figure 22 MOSFET

Gate voltage vs Gate charge

$$V_{GE} = f(Q_g)$$

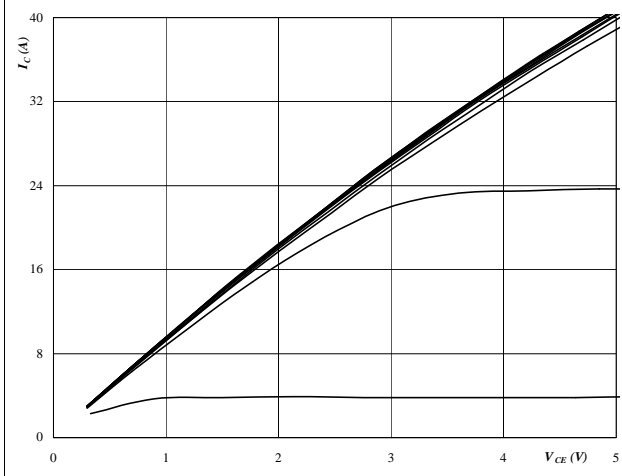

At
 $I_D = 47$ A

Boost and Buck

Figure 1 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

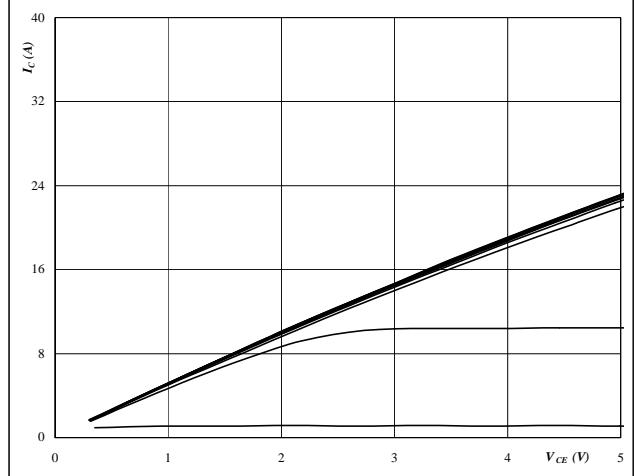


At
 $t_p = 250 \mu s$
 $T_j = 25 \text{ } ^\circ C$
 V_{GE} from 6 V to 16 V in steps of 1 V

Figure 2 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

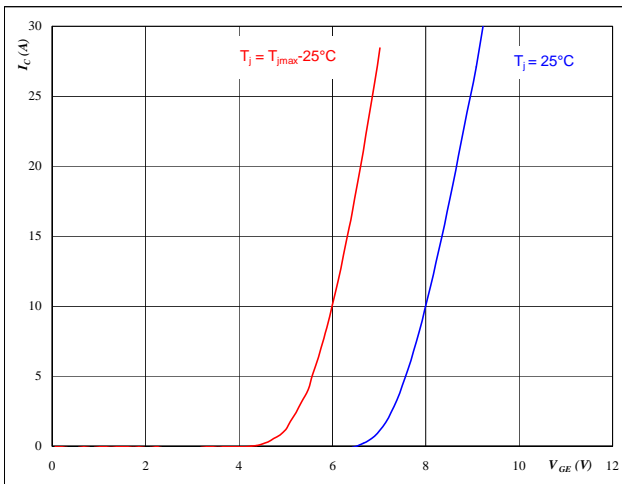


At
 $t_p = 250 \mu s$
 $T_j = 125 \text{ } ^\circ C$
 V_{GE} from 5 V to 15 V in steps of 1 V

Figure 3 IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

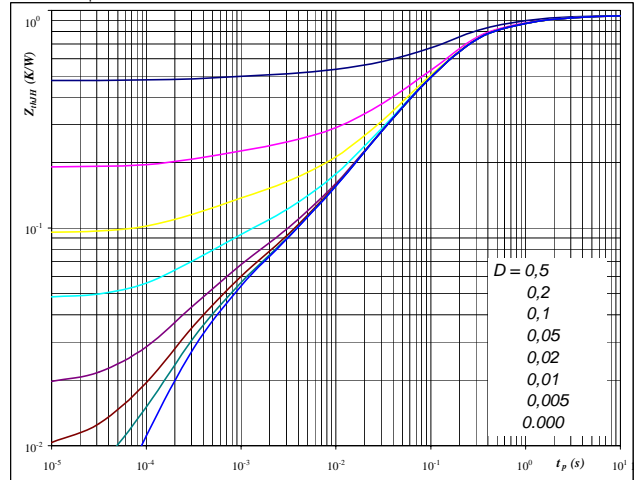


At
 $t_p = 250 \mu s$
 $V_{CE} = 10 V$

Figure 4 IGBT

IGBT transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At
 $D = t_p / T$
 $R_{thJH} = 0,95 K/W$

Input Boost

Figure 1 BOOST MOSFET

Typical output characteristics

$I_D = f(V_{DS})$

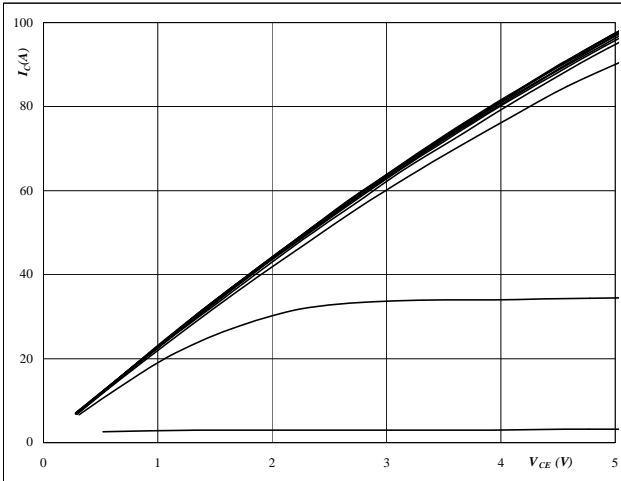

At
 $t_p = 250 \mu s$
 $T_j = 25 \text{ } ^\circ C$
 V_{GS} from 4 V to 14 V in steps of 1 V

Figure 2 BOOST FRED

Typical output characteristics

$I_D = f(V_{DS})$

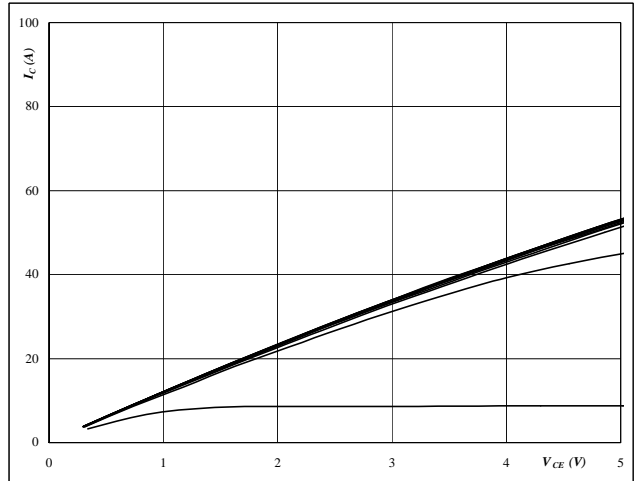
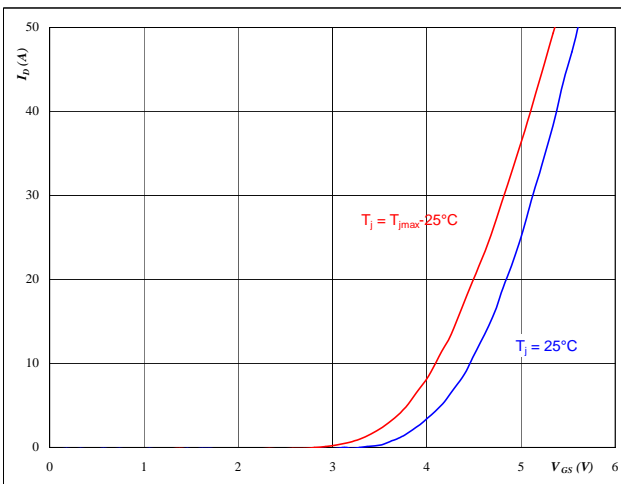

At
 $t_p = 250 \mu s$
 $T_j = 126 \text{ } ^\circ C$
 V_{GS} from 4 V to 14 V in steps of 1 V

Figure 2 BOOST MOSFET

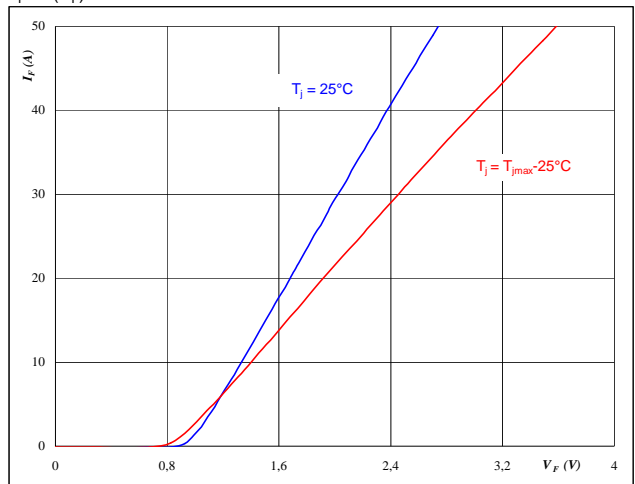
Typical transfer characteristics

$I_D = f(V_{DS})$


At
 $t_p = 250 \mu s$
 $V_{DS} = 10 \text{ V}$
Figure 3 BOOST FRED

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

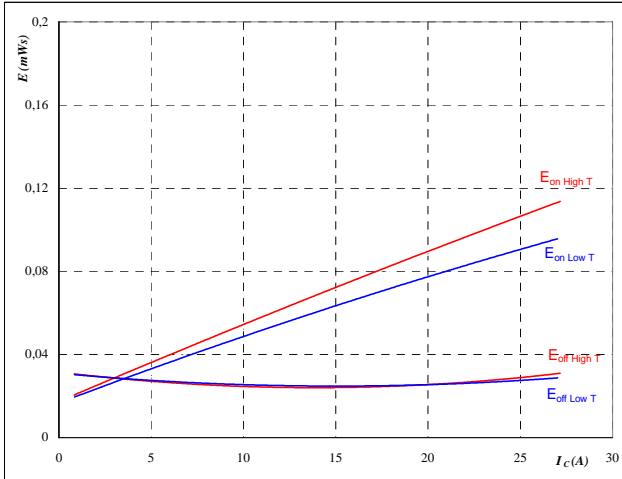

At
 $t_p = 250 \mu s$

Input Boost

Figure 4 BOOST MOSFET

**Typical switching energy losses
as a function of collector current**

$$E = f(I_D)$$



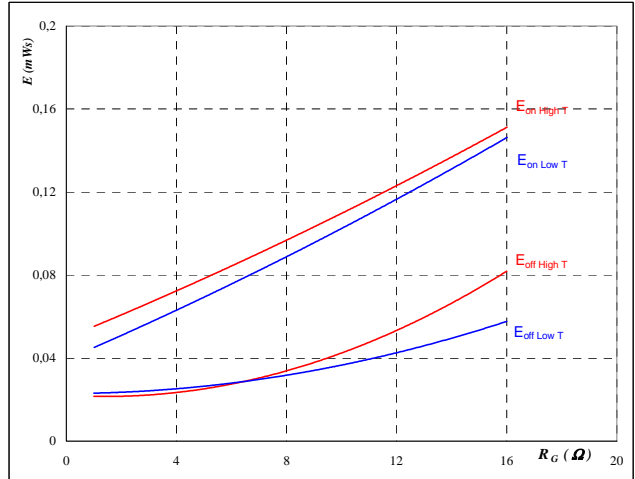
With an inductive load at

$T_J =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	10	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

Figure 5 BOOST MOSFET

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



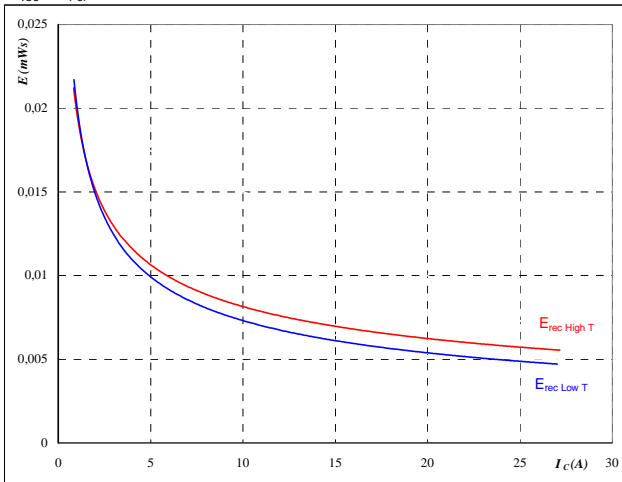
With an inductive load at

$T_J =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	10	V
$I_D =$	15	A

Figure 6 BOOST MOSFET

**Typical reverse recovery energy loss
as a function of collector (drain) current**

$$E_{rec} = f(I_C)$$



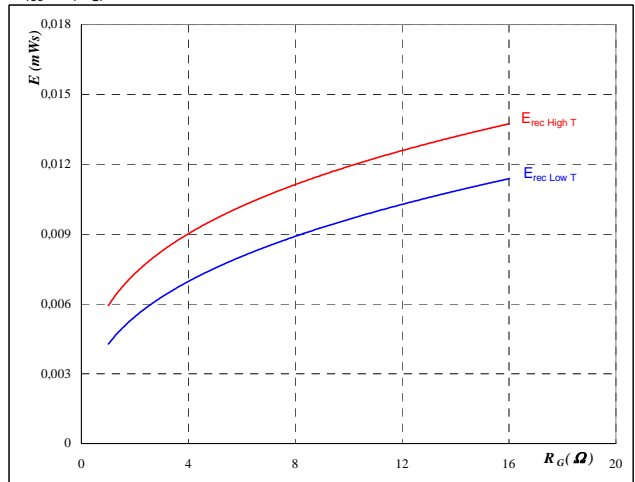
With an inductive load at

$T_J =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	10	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

Figure 7 BOOST MOSFET

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



With an inductive load at

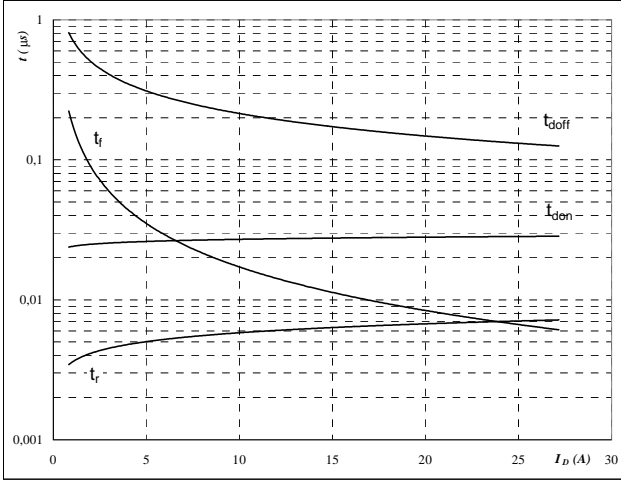
$T_J =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	10	V
$I_D =$	15	A

Input Boost

Figure 8 BOOST MOSFET

Typical switching times as a function of collector current

$$t = f(I_C)$$



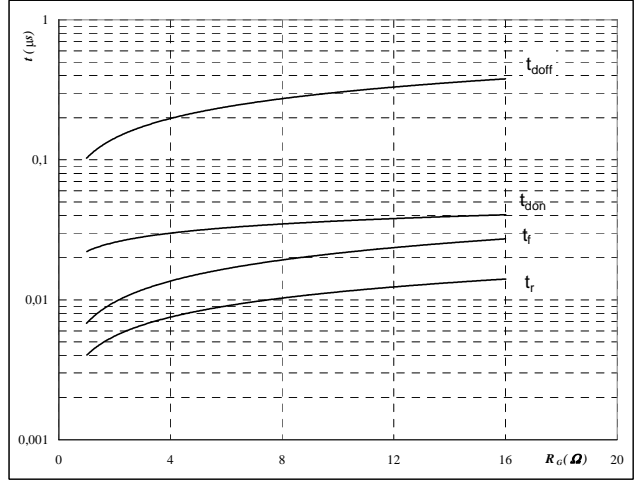
With an inductive load at

$T_J =$	125	°C
$V_{DS} =$	400	V
$V_{GS} =$	10	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

Figure 9 BOOST MOSFET

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



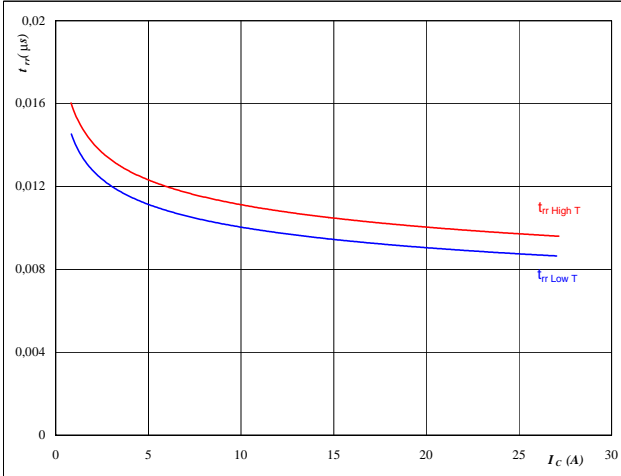
With an inductive load at

$T_J =$	125	°C
$V_{DS} =$	400	V
$V_{GS} =$	10	V
$I_C =$	15	A

Figure 10 BOOST FRED

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



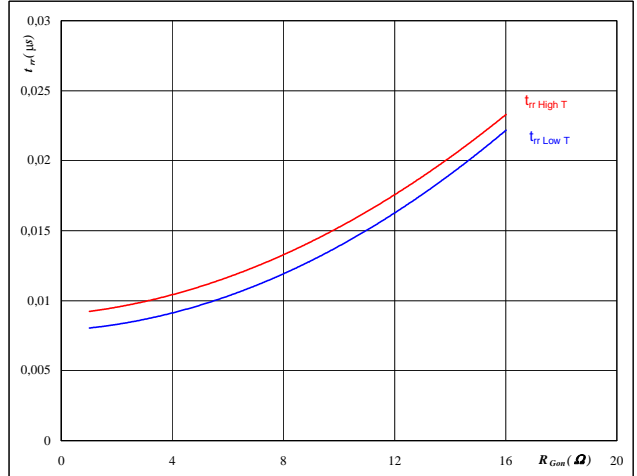
At

$T_J =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	4	Ω

Figure 11 BOOST FRED

Typical reverse recovery time as a function of MOSFET turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

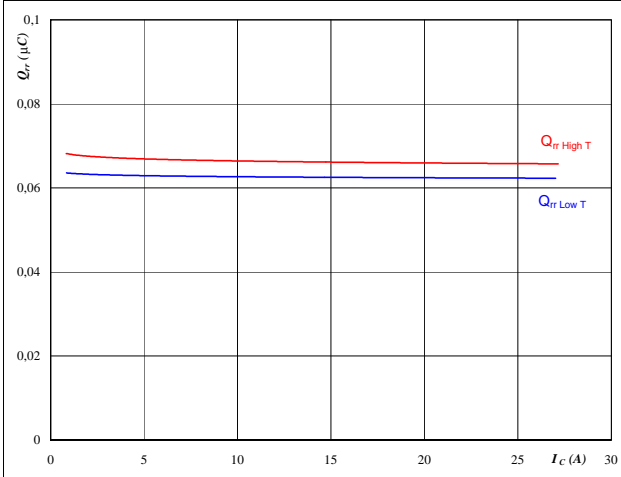
$T_J =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GS} =$	10	V

Input Boost

Figure 12 BOOST FRED

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_c)$$



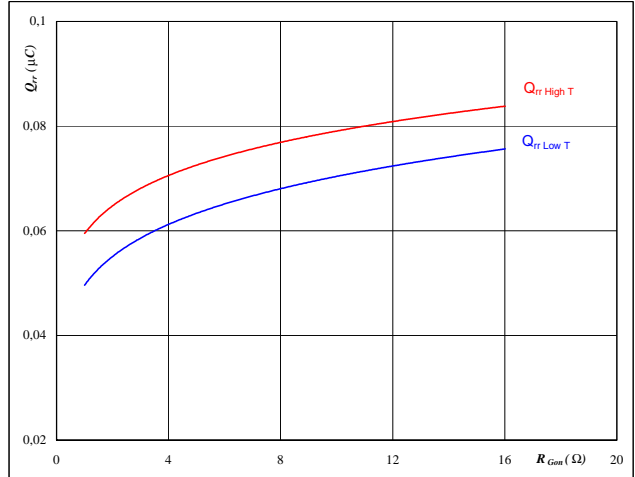
At

$T_j =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	4	Ω

Figure 13 BOOST FRED

Typical reverse recovery charge as a function of MOSFET turn on gate resistor

$$Q_{rr} = f(R_{gon})$$



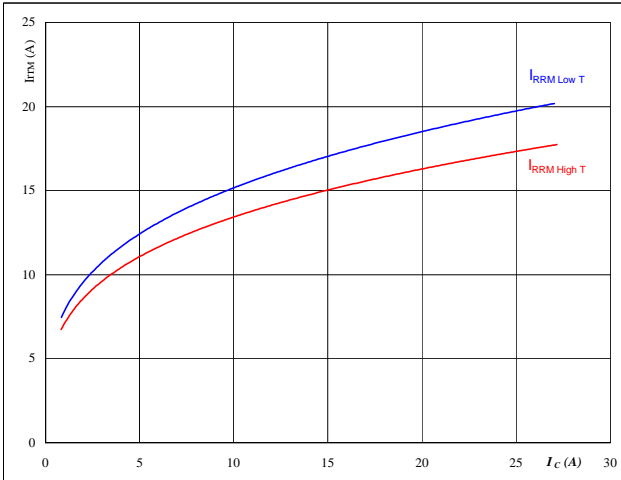
At

$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GS} =$	10	V

Figure 14 BOOST FRED

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_c)$$



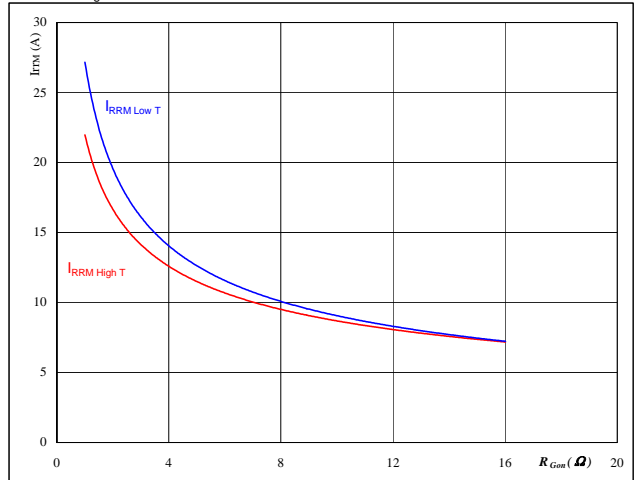
At

$T_j =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	10	V
$R_{gon} =$	4	Ω

Figure 15 BOOST FRED

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



At

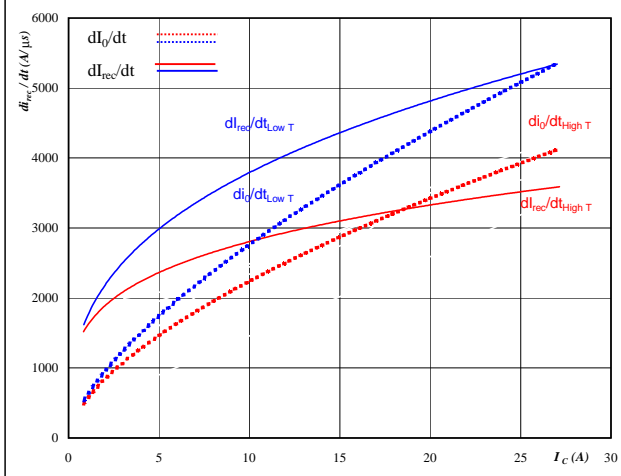
$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GS} =$	10	V

Input Boost

Figure 16 BOOST FRED

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$dI_o/dt, dI_{rec}/dt = f(I_c)$$

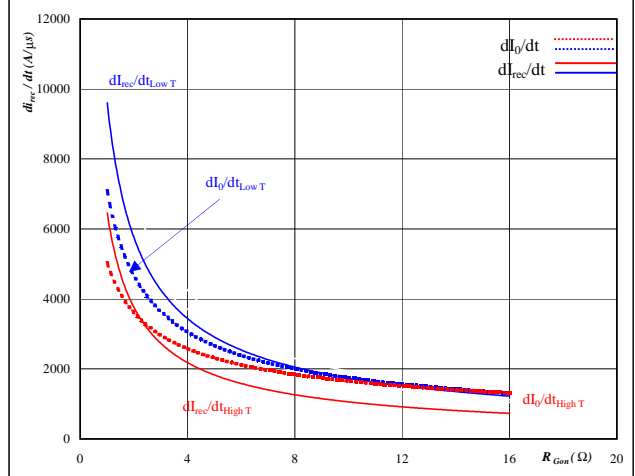


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 400 \text{ V}$
 $V_{GE} = 10 \text{ V}$
 $R_{gon} = 4 \text{ } \Omega$

Figure 17 BOOST FRED

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$dI_o/dt, dI_{rec}/dt = f(R_{gon})$$

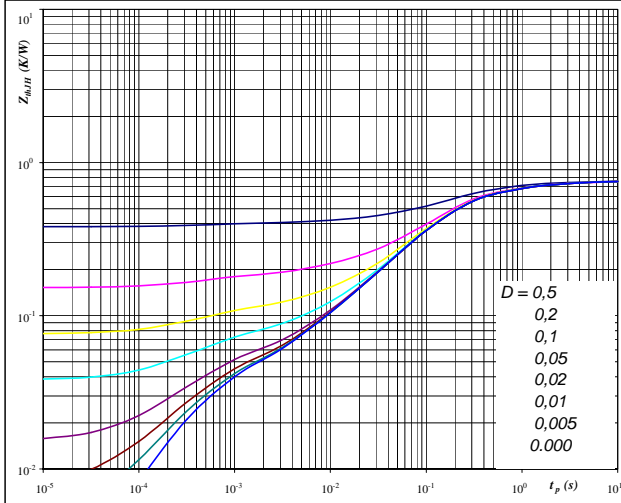


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 400 \text{ V}$
 $I_F = 15 \text{ A}$
 $V_{GS} = 10 \text{ V}$

Figure 18 BOOST MOSFET

IGBT/MOSFET transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 0,76 \text{ K/W}$

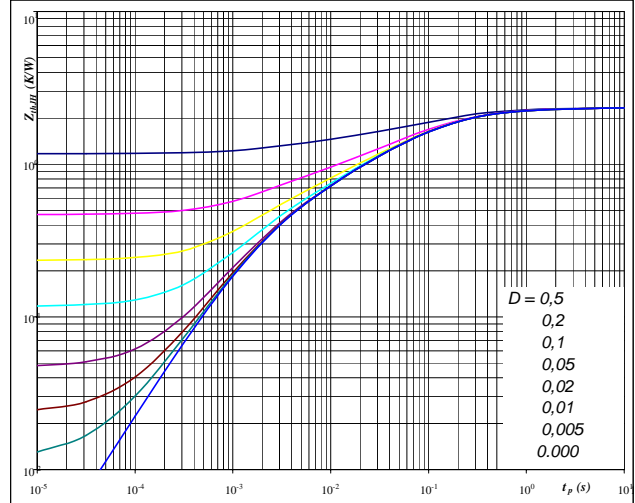
IGBT thermal model values

R (C/W)	Tau (s)
0,03247	9,971
0,1223	1,22
0,4264	0,1797
0,1173	0,04698
0,03103	0,005891
0,03298	0,0004038

Figure 19 BOOST FRED

FRED transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 2,34 \text{ K/W}$

FRED thermal model values

R (C/W)	Tau (s)
0,1024	2,885
0,495	0,3437
0,9886	0,07039
0,4865	0,01004
0,2673	0,001614

Input Boost

Figure 20 BOOST MOSFET

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

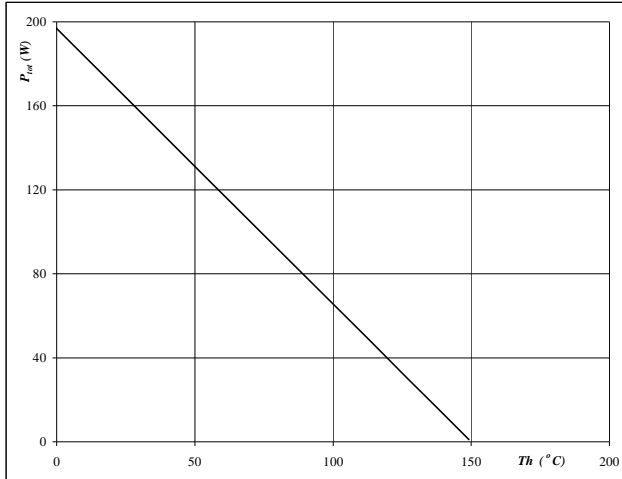

At
 T_j = 150 °C

Figure 21 BOOST MOSFET

Collector/Drain current as a function of heatsink temperature

$$I_C = f(T_h)$$

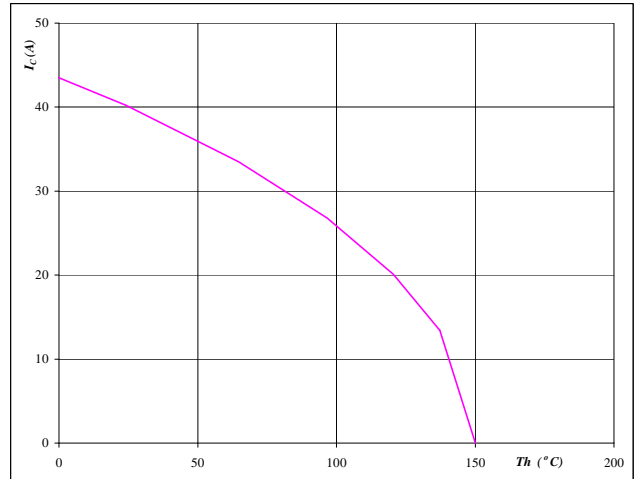

At
 T_j = 150 °C
 V_{GS} = 10 V

Figure 22 BOOST FRED

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

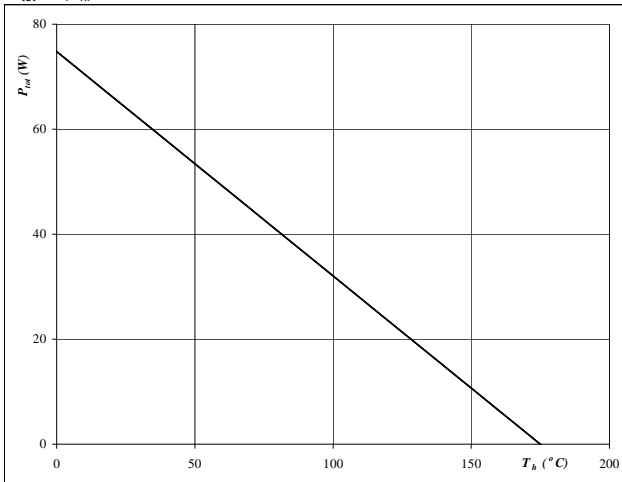
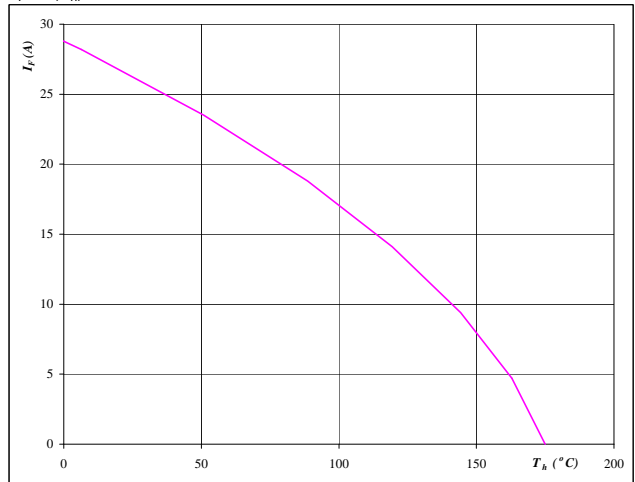

At
 T_j = 175 °C

Figure 23 BOOST FRED

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

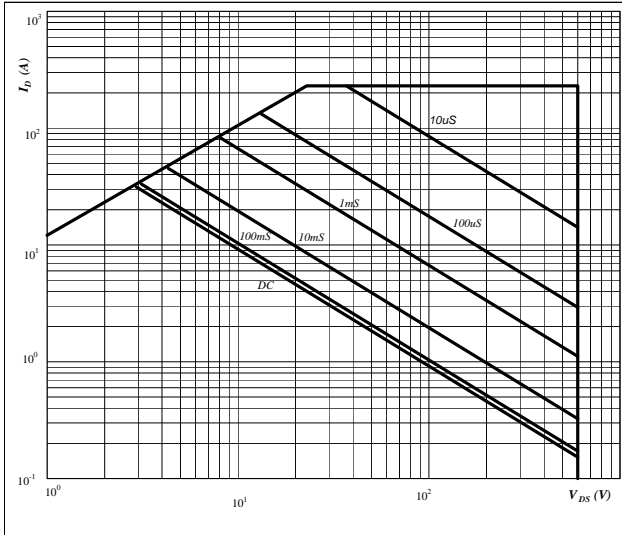

At
 T_j = 175 °C

Input Boost

Figure 24 BOOST MOSFET

Safe operating area as a function of drain-source voltage

$$I_D = f(V_{DS})$$

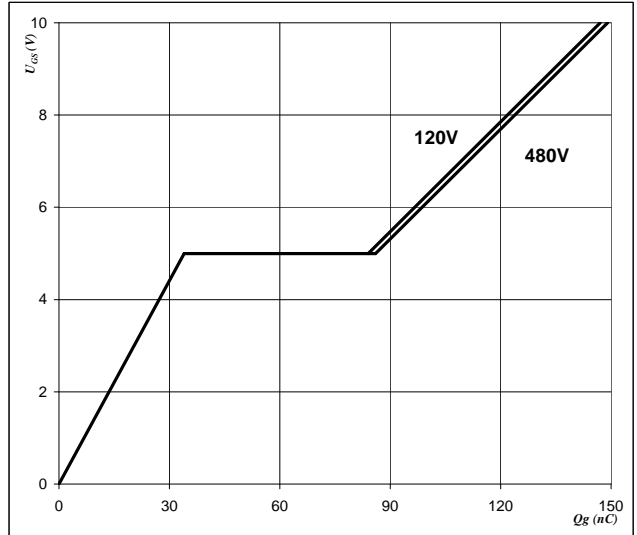


At
 D = single pulse
 $T_h = 80 \text{ } ^\circ\text{C}$
 $V_{GS} = 10 \text{ V}$
 $T_j = T_{jmax} \text{ } ^\circ\text{C}$

Figure 25 BOOST MOSFET

Gate voltage vs Gate charge

$$V_{GS} = f(Q_g)$$



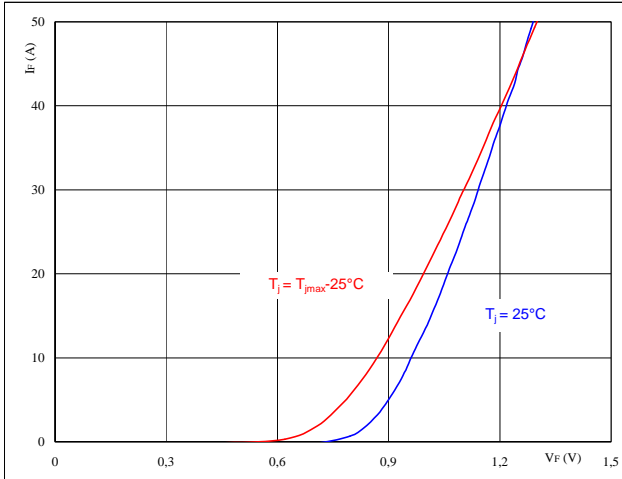
At
 $I_D = 44 \text{ A}$

Bypass Diode

Figure 1 Bypass diode

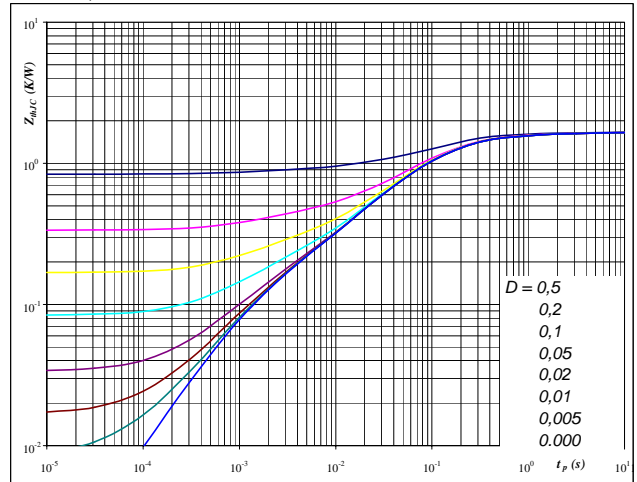
Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$


At
 $t_p = 250 \mu s$
Figure 2 Bypass diode

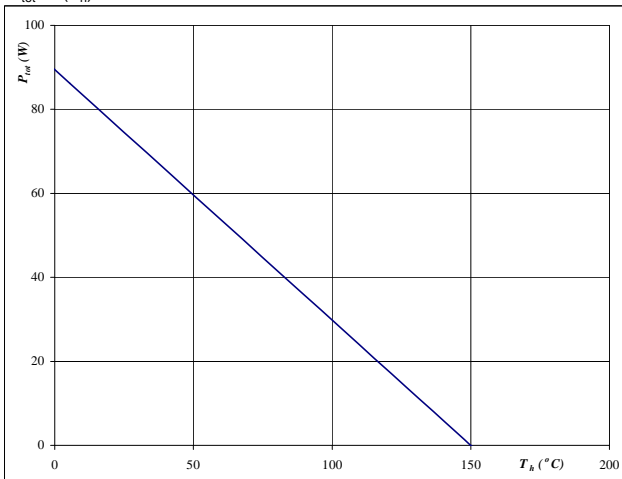
Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At
 $D = t_p / T$
 $R_{thJH} = 1,677 \text{ K/W}$
Figure 3 Bypass diode

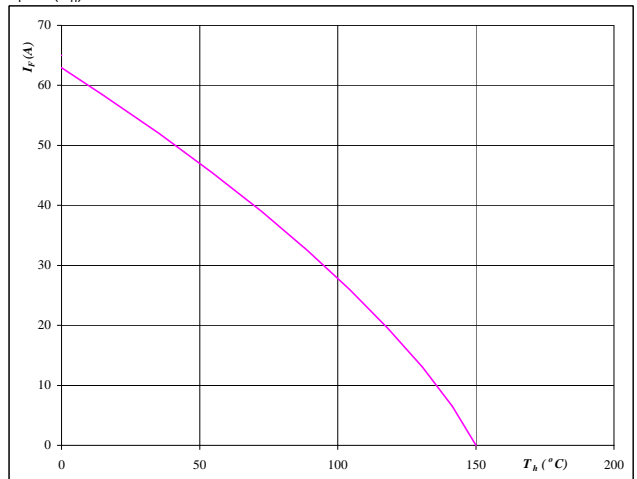
Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$


At
 $T_j = 150 \text{ }^\circ\text{C}$
Figure 4 Bypass diode

Forward current as a function of heatsink temperature

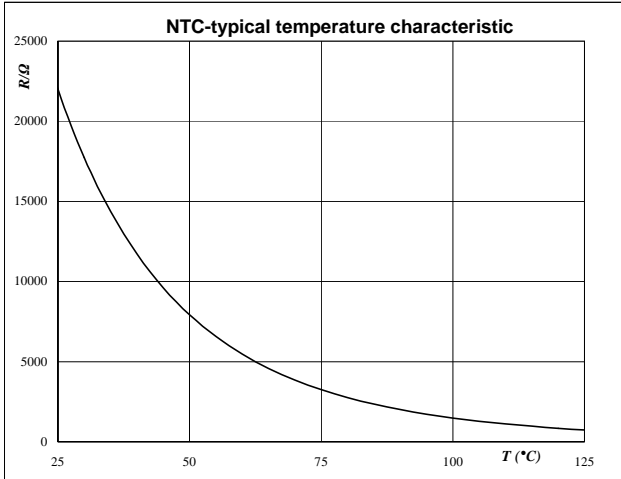
$$I_F = f(T_h)$$


At
 $T_j = 150 \text{ }^\circ\text{C}$

Thermistor

Figure 1 Thermistor

Typical NTC characteristic
 as a function of temperature

 $R_T = f(T)$

Figure 2 Thermistor

Typical NTC resistance values

$$R(T) = R_{25} \cdot e^{\left(B_{25/100} \left(\frac{1}{T} - \frac{1}{T_{25}} \right) \right)} \quad [\Omega]$$

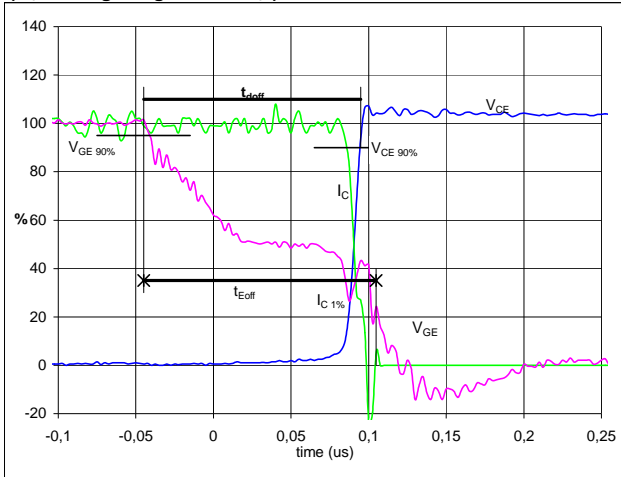
T [°C]	R _{nom} [Ω]	R _{min} [Ω]	R _{max} [Ω]	ΔR/R [±%]
-55	2089434,5	1506495,4	2672373,6	27,9
0	71804,2	59724,4	83884	16,8
10	43780,4	37094,4	50466,5	15,3
20	27484,6	23684,6	31284,7	13,8
25	22000	19109,3	24890,7	13,1
30	17723,3	15512,2	19934,4	12,5
60	5467,9	4980,6	5955,1	8,9
70	3848,6	3546	4151,1	7,9
80	2757,7	2568,2	2947,1	6,9
90	2008,9	1889,7	2128,2	5,9
100	1486,1	1411,8	1560,4	5
150	400,2	364,8	435,7	8,8

Switching Definitions BUCK MOSFET

General conditions

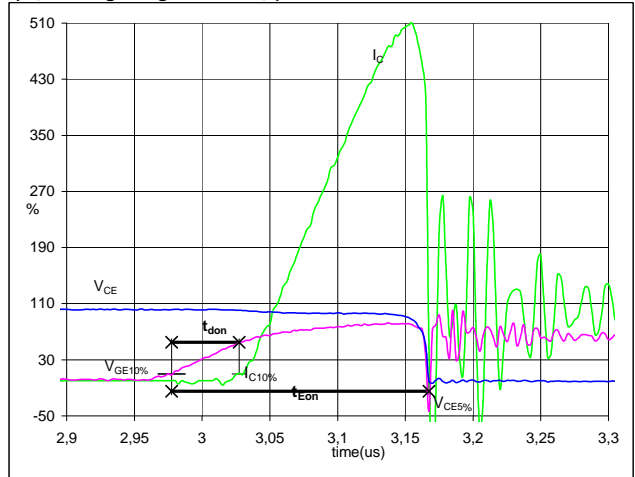
T_j	=	124 °C
R_{gon}	=	16 Ω
R_{goff}	=	4 Ω

Figure 1 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 (t_{Eoff} = integrating time for E_{off})


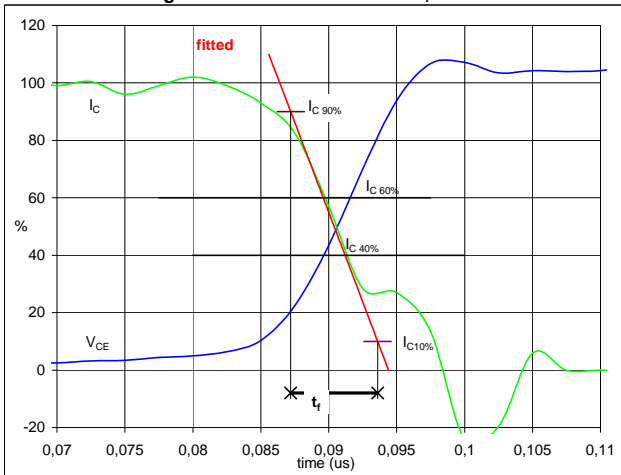
V_{GE} (0%) =	0	V
V_{GE} (100%) =	10	V
V_C (100%) =	400	V
I_C (100%) =	15	A
t_{doff} =	0,13	μ s
t_{Eoff} =	0,15	μ s

Figure 2 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 (t_{Eon} = integrating time for E_{on})


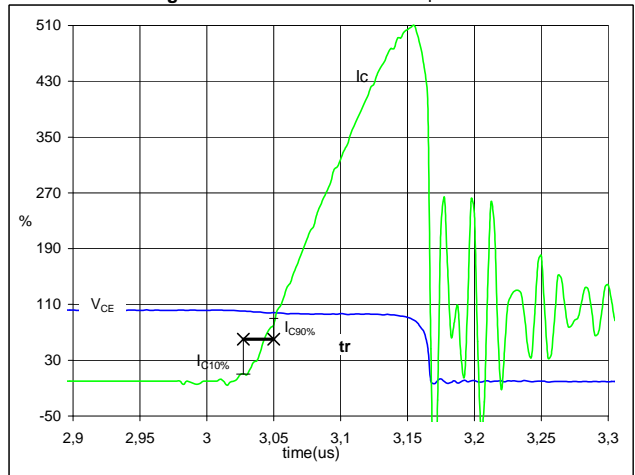
V_{GE} (0%) =	0	V
V_{GE} (100%) =	10	V
V_C (100%) =	400	V
I_C (100%) =	15	A
t_{don} =	0,06	μ s
t_{Eon} =	0,19	μ s

Figure 3 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_f


V_C (100%) =	400	V
I_C (100%) =	15	A
t_f =	0,01	μ s

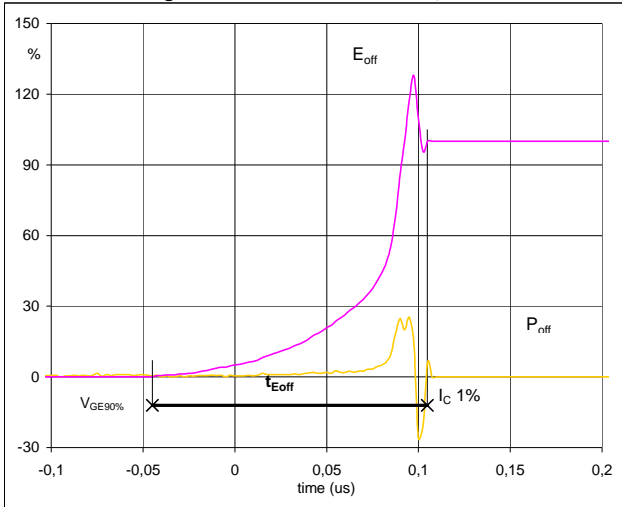
Figure 4 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_r


V_C (100%) =	400	V
I_C (100%) =	15	A
t_r =	0,02	μ s

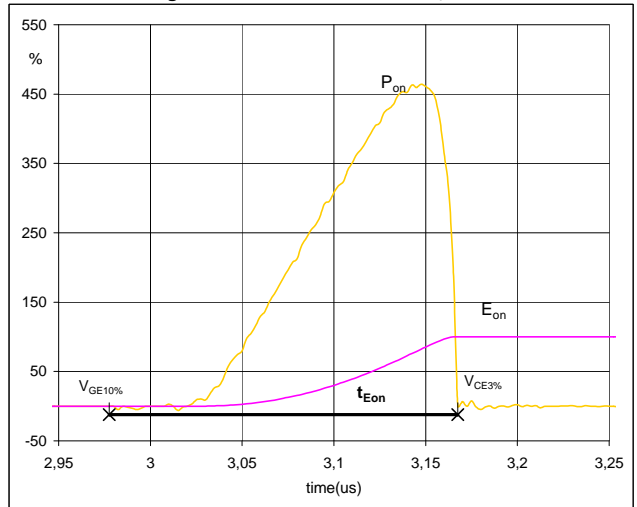
Switching Definitions BUCK MOSFET

Figure 5 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{Eoff}


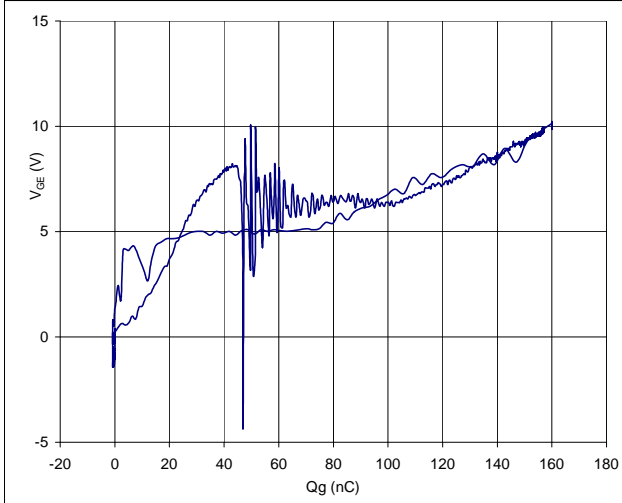
$P_{off}(100\%) = 6,13$ kW
 $E_{off}(100\%) = 0,02$ mJ
 $t_{Eoff} = 0,15$ μ s

Figure 6 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_{Eon}


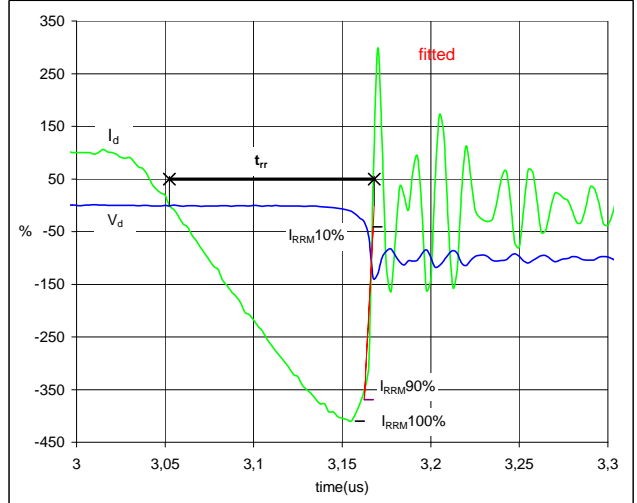
$P_{on}(100\%) = 6,13$ kW
 $E_{on}(100\%) = 2,27$ mJ
 $t_{Eon} = 0,19$ μ s

Figure 7 Output inverter FRED

Gate voltage vs Gate charge (measured)


$V_{GEoff} = 0$ V
 $V_{GEon} = 10$ V
 $V_C(100\%) = 400$ V
 $I_C(100\%) = 15$ A
 $Q_g = 159,93$ nC

Figure 8 Output inverter IGBT

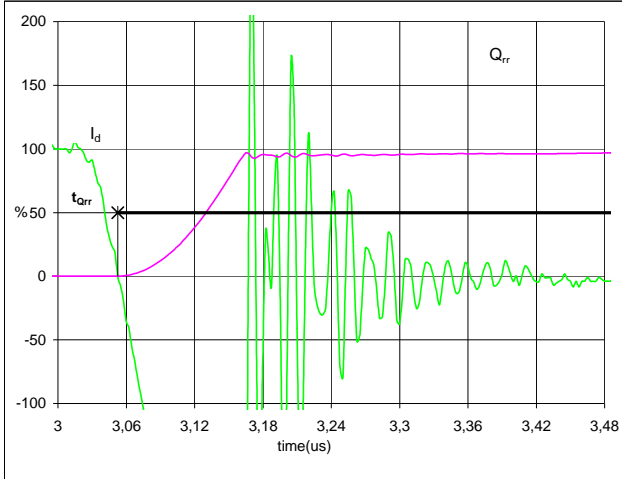
Turn-off Switching Waveforms & definition of t_{rr}


$V_d(100\%) = 400$ V
 $I_d(100\%) = 15$ A
 $I_{RRM}(100\%) = -63$ A
 $t_{rr} = 0,11$ μ s

Switching Definitions BUCK MOSFET

Figure 9 Output inverter FRED

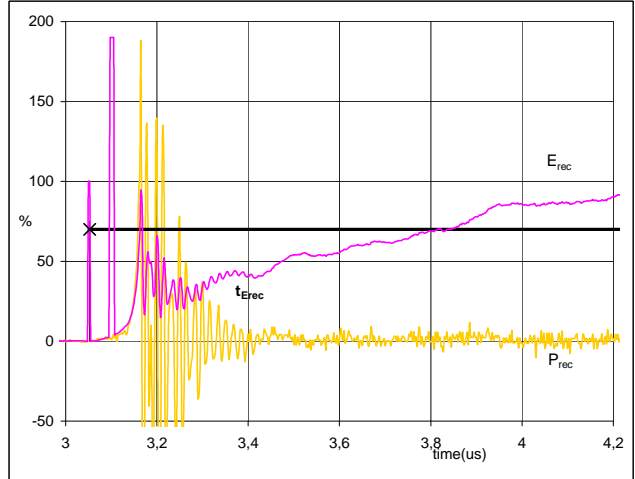
Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})



I_d (100%) = 15 A
 Q_{rr} (100%) = 4,31 μ C
 t_{Qrr} = 300000,00 μ s

Figure 10 Output inverter FRED

Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})

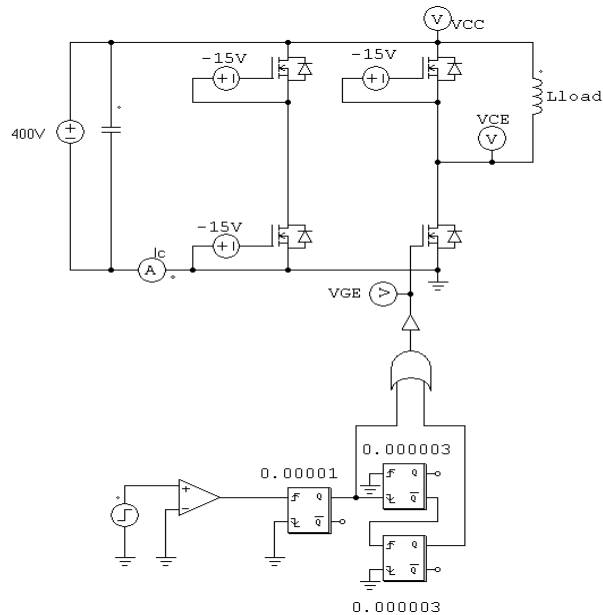


P_{rec} (100%) = 6,13 kW
 E_{rec} (100%) = 0,17 mJ
 t_{Erec} = ##### μ s

Measurement circuits

Figure 11

BUCK stage switching measurement circuit



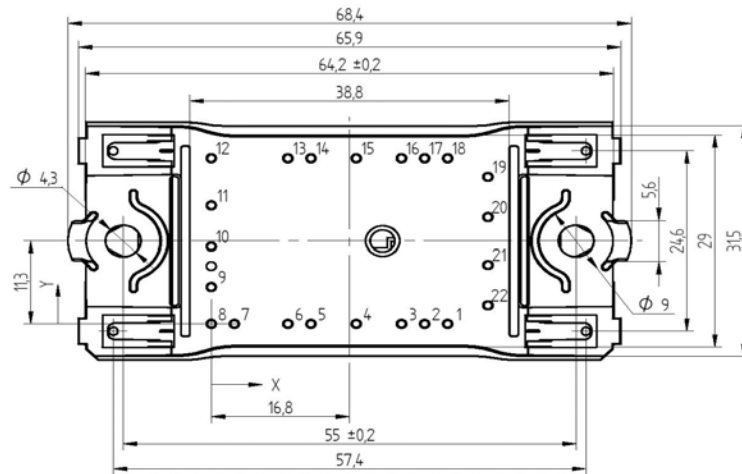
Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking

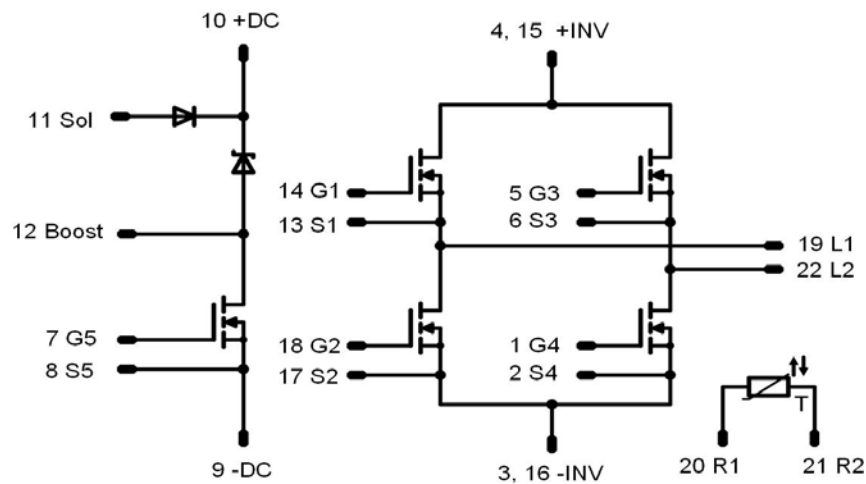
Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 12mm housing	10-FZ06BIA083FI-P896E	P896E	P896E

Outline

Pin table		
Pin	X	Y
1	28,7	0
2	25,9	0
3	23,1	0
4	17,6	0
5	12,1	0
6	9,3	0
7	2,8	0
8	0	0
9	0	5,05
10	0	10,55
11	0	16,15
12	0	22,6
13	9,3	22,6
14	12,1	22,6
15	17,6	22,6
16	23,1	22,6
17	25,9	22,6
18	28,7	22,6
19	33,6	20,05
20	33,6	14,55
21	33,6	8,05
22	33,6	2,55



Pinout



PRODUCT STATUS DEFINITIONS

Datasheet Status	Product Status	Definition
Target	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. The data contained is exclusively intended for technically trained staff.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data may be published at a later date. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.
Final	Full Production	This datasheet contains final specifications. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.

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LIFE SUPPORT POLICY

Vincotech products are not authorised for use as critical components in life support devices or systems without the express written approval of Vincotech.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in labelling can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.